

Search Notes

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10/714,839

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Alain L. Bashore

Applicant(s)/Patent under
Reexamination

TAKAHASHI ET AL.

Art Unit

1762

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
427	126,131	11/9/2006	AB
428	694st	11/9/2006	AB
428	694sl	11/9/2006	AB
428/694bs		11/9/2006	ab

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
previos search updated	11/9/2006	ab